SemTron Microtech Corporation

SMC4549M

Complementary MOSFET

■DESCRIPTION

The SMC4549 is the N+P-Channel Complementary mode power field effect transistors are using trench DMOS technology. advanced trench technology to provide excellent $R_{DS(ON)}$.
This device is widely preferred for commercial-industrial surface mount applications and suited for low voltage applications such.

■PART NUMBER INFORMATION

SMC 4549 M - TR G
a b c d e

a : Company name.
b : Product Serial number.
c : Package code M:SOP-8
d : Handling code TR:Tape&Reel
e : Green produce code G:*RoHS Compliant*

■FEATURES

N-Channel

V_{DS} = 30V, I_D = 7.8A

$R_{DS(ON)}$=16mΩ(Typ.)@V_{GS}=10V
$R_{DS(ON)}$=20mΩ(Typ.)@V_{GS}=4.5V

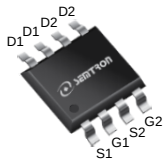
P-Channel

V_{DS} = -30V, I_D = -7A

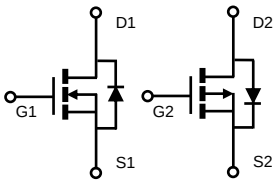
$R_{DS(ON)}$=20mΩ(Typ.)@V_{GS}=-10V
$R_{DS(ON)}$=26mΩ(Typ.)@V_{GS}=-4.5V

■APPLICATIONS

◆Hight Frequency Synchronous Buck DC-DC Converter
◆Portable Equipment and Battery Powered



SOP-8



N-ch P-ch

■ABSOLUTE MAXIMUM RATINGS (T_A = 25°C Unless otherwise noted)

Symbol	Parameter		Rating N-ch	Rating P-ch	Units
V_{DSS}	Drain-Source Voltage		30	-30	V
V_{GSS}	Gate-Source Voltage		±20	±20	V
I_D	Continuous Drain Current	T_A=25°C	7.8	-7	A
		T_A=70°C	6.5	-5.8	A
I_{DM}	Pulsed Drain Current [A]		31.2	-28	A
I_{AS}	Avalanche Current [A]		20	-25	A
E_{AS}	Single Pulse Avalanche energy L=0.3mH [AF]		60	93	mJ
P_D	Power Dissipation [B]	T_A=25°C	2	2.1	W
		T_A=70°C	1.3	1.3	W
T_J	Operation Junction Temperature		-55/150		°C
T_{STG}	Storage Temperature Range		-55/150		°C

■THERMAL RESISTANCE

Symbol	Parameter		Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient [B]	t≦10s		62	°C/W
	Thermal Resistance Junction to Ambient [BD]	Steady-State		100	

■N-ch ELECTRICAL CHARACTERISTICS(T_A = 25°C Unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
Static Parameters						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=250μA	30			V
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_D=250μA	1	1.5	2.5	V
I_{GSS}	Gate Leakage Current	V_{DS}=0V, V_{GS}=±20V			±100	nA
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=30V, V_{GS}=0V, T_J=25°C			1	μA
		V_{DS}=24V, V_{GS}=0V, T_J=75°C			10	
$R_{DS(ON)}$	Drain-source On-Resistance [E]	V_{GS}=10V, I_D=7.8A V_{GS}=4.5V, I_D=6A		16 20	20 28	mΩ
G_{fs}	Forward Transconductance	V_{DS}=15V, I_D=6A		12		S
Diode Characteristics						
V_{SD}	Diode Forward Voltage [E]	I_S=1A, V_{GS}=0V		0.7	1	V
I_S	Continuous Source Current				3.9	A
Dynamic and Switching Parameters						
Q_g	Total Gate Charge (10V)	V_{DS}=15V, V_{GS}=10V, I_D=6.5A		8.4	11.8	nC
Q_g	Total Gate Charge (4.5V)			4.2	5.9	
Q_{gs}	Gate-Source Charge			1.6	2.2	
Q_{gd}	Gate-Drain Charge			2	2.8	
C_{iss}	Input Capacitance	V_{DS}=15V, V_{GS}=0V, f=1MHz		420	588	pF
C_{oss}	Output Capacitance			62	87	
C_{rss}	Reverse Transfer Capacitance			50	70	
$t_{d(on)}$	Turn-On Time	V_{DD}=15V, V_{GEN}=10V, R_G=6Ω, I_D=1A		5.3	10	nS
t_r				7.6	14	
$t_{d(off)}$	Turn-Off Time			15.8	30	
t_f				4.2	8	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

A. Pulsed width limited by maximum junction temperature, $T_{J(MAX)}$=150°C.
B. The value of $R_{\theta JA}$ is measured with the device mounted on 1in2 FR-4 board in a still air environment with maximum junction temperature $T_{J(MAX)}$=150°C (initial temperature TA=25°C).
C. $T_{J(MAX)}$=150°C,using junction-to-ambient thermal resistance, t ≦10sec.
D. $T_{J(MAX)}$=150°C,using junction-to-case thermal resistance ($R_{\theta JC}$) is more useful in additional heat sinking is used.
E. The data tested by pulsed , pulse width ≦ 300uS , duty cycle ≦ 2%.
F. The EAS data shows Max, tested and pulse width limited by $T_{J(MAX)}$=150°C (initial temperature T_J=25°C).

P-ch ELECTRICAL CHARACTERISTICS(T_A = 25°C Unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
Static Parameters						
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=-250μA	-30			V
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_D=-250μA	-1	-1.6	-2.5	V
I_{GSS}	Gate Leakage Current	V_{DS}=0V, V_{GS}=±20V			±100	nA
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=-30V, V_{GS}=0V, T_J=25°C			-1	μA
		V_{DS}=-24V, V_{GS}=0V, T_J=75°C			-10	
$R_{DS(ON)}$	Drain-source On-Resistance [E]	V_{GS}=-10V, I_D=-7A V_{GS}=-4.5V, I_D=-5.6A		20 26	25 32	mΩ
G_{fs}	Forward Transconductance	V_{DS}=-10V, I_D=-7A		24		S
Diode Characteristics						
V_{SD}	Diode Forward Voltage [E]	I_S=-1A,V_{GS}=0V		-0.7	-1	V
I_S	Continuous Source Current				-3.5	A
Dynamic and Switching Parameters						
Q_g	Total Gate Charge (10V)	V_{DS}=-15V,V_{GS}=-10V, I_D=-7A		23.6	33	nC
Q_g	Total Gate Charge (4.5V)			11.5	16.1	
Q_{gs}	Gate-Source Charge			3.5	4.9	
Q_{gd}	Gate-Drain Charge			4.8	6.7	
C_{iss}	Input Capacitance	V_{DS}=-15V,V_{GS}=0V, f=1MHz		1280		pF
C_{oss}	Output Capacitance			19		
C_{rss}	Reverse Transfer Capacitance			103		
R_g	Gate Resistance	V_{GS}=0V, V_{DS}=0V, F=1MHz		8.8		Ω
$t_{d(on)}$	Turn-On Time	V_{DD}=-15V, V_{GEN}=-10V, R_G=6Ω, I_D=-1A		10	19	nS
t_r				18.2	35	
$t_{d(off)}$	Turn-Off Time			43	82	
t_f				11.3	21	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

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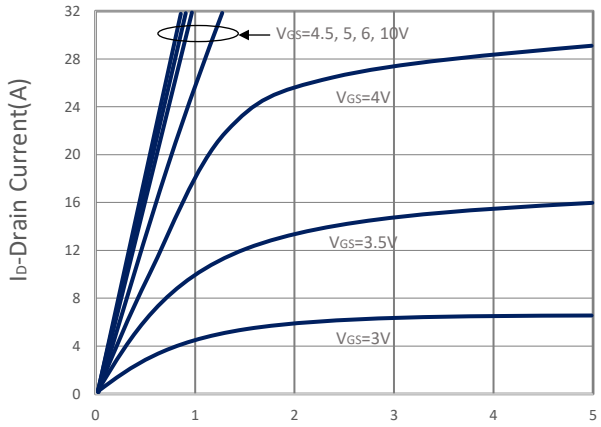
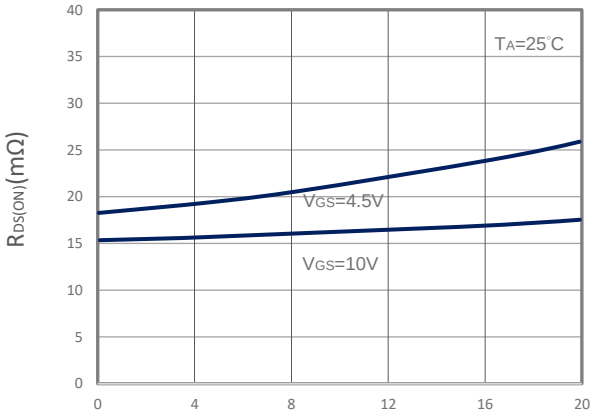
B. The value of $R_{\theta JA}$ is measured with the device mounted on 1in2 FR-4 board in a still air environment with maximum junction temperature $T_{J(MAX)}$=150°C (initial temperature TA=25°C).
C. $T_{J(MAX)}$=150°C,using junction-to-ambient thermal resistance, t ≦10sec.
D. $T_{J(MAX)}$=150°C,using junction-to-case thermal resistance ($R_{\theta JC}$) is more useful in additional heat sinking is used.
E. The data tested by pulsed , pulse width ≦ 300uS , duty cycle ≦ 2%.
F. The EAS data shows Max, tested and pulse width limited by $T_{J(MAX)}$=150°C (initial temperature T_J=25°C).

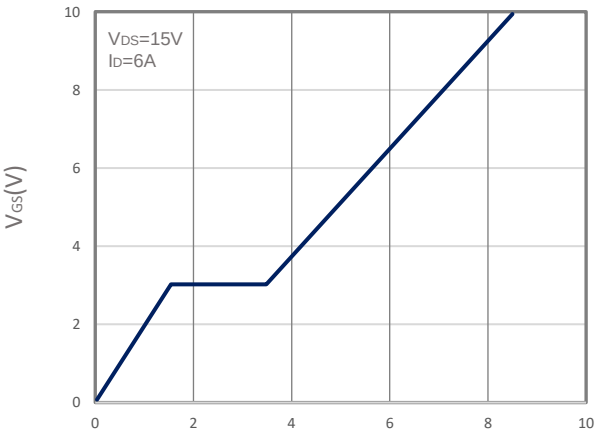
■N-ch TYPICAL CHARACTERISTICS



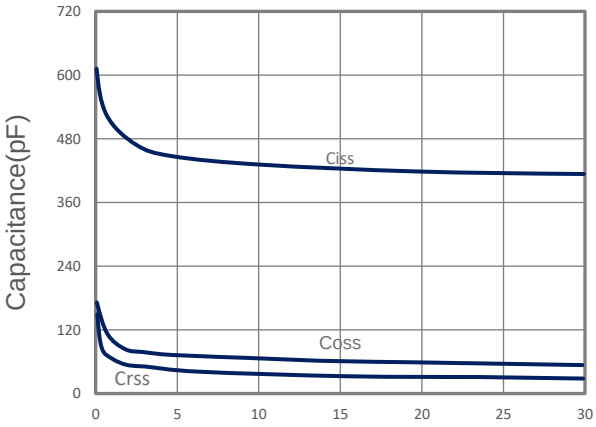
Output Characteristics



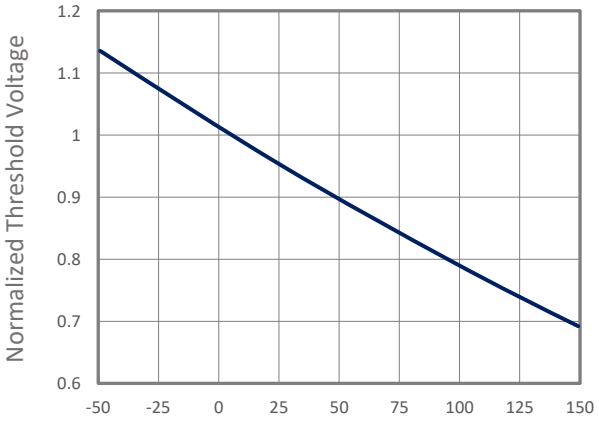
Drain-Source On Resistance



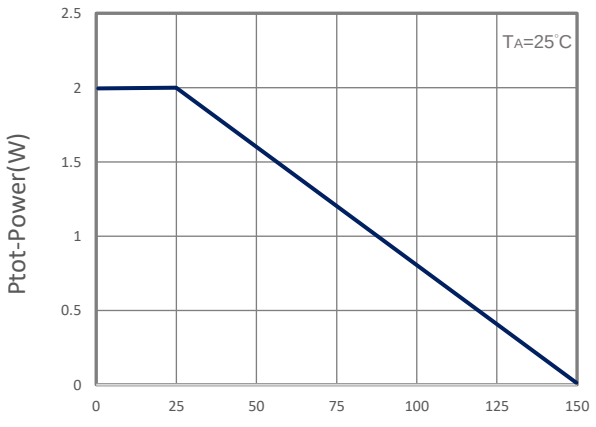
Gate Charge



Capacitance

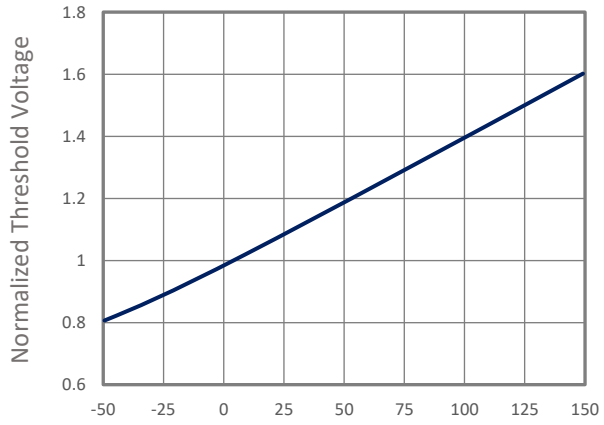


Gate Threshold Voltage

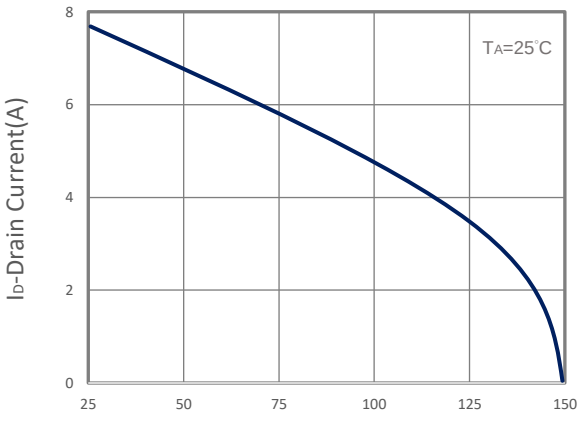


Power Dissipation

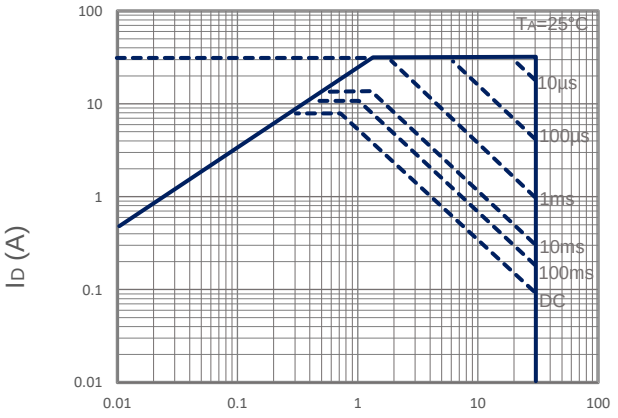
■N-ch TYPICAL CHARACTERISTICS



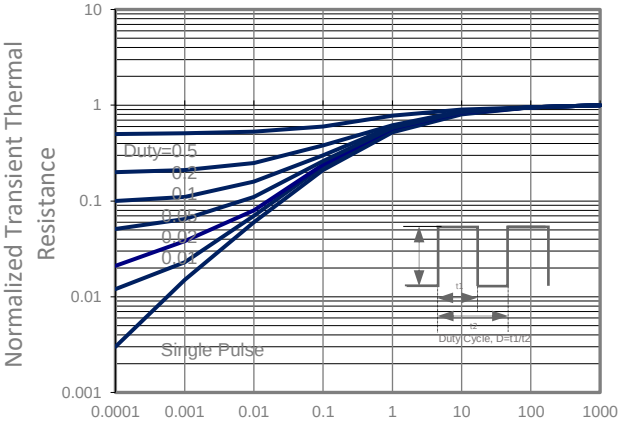
Gate Threshold Voltage



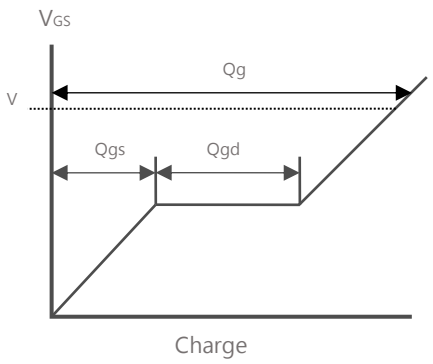
Drain Current vs TJ



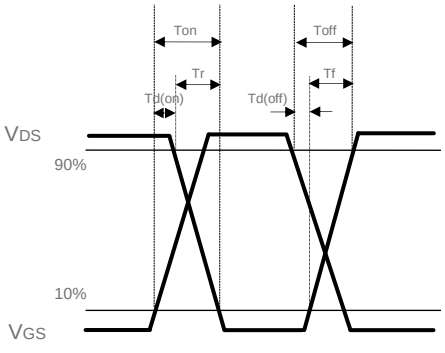
Maximum Safe Operation Area



Thermal Transient Impedance

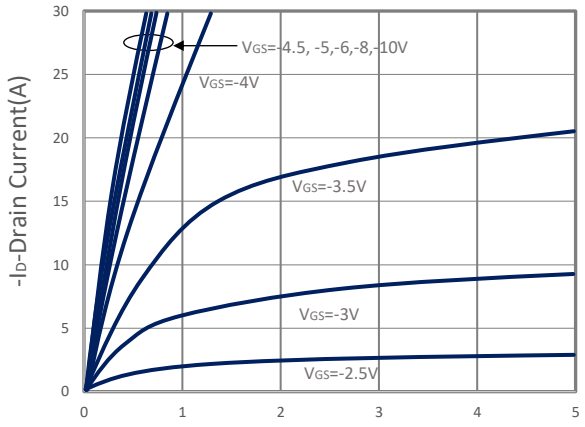


Gate Chrge Waveform

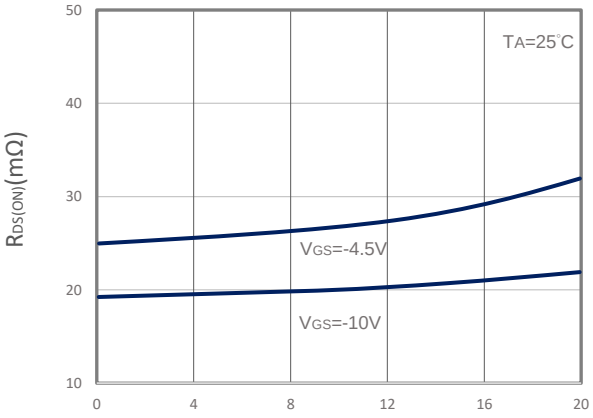


Switching Time Waveform

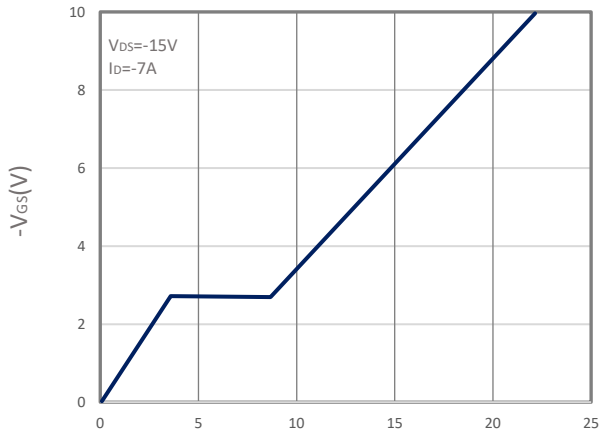
■P-ch TYPICAL CHARACTERISTICS



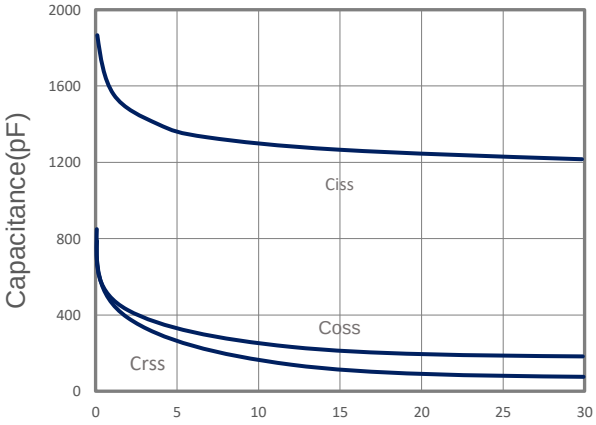
Output Characteristics



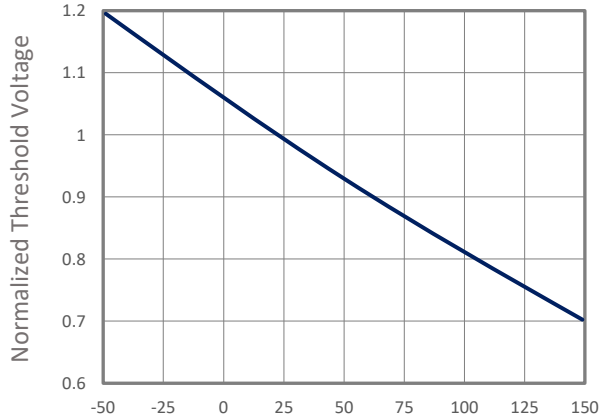
Drain-Source On Resistance



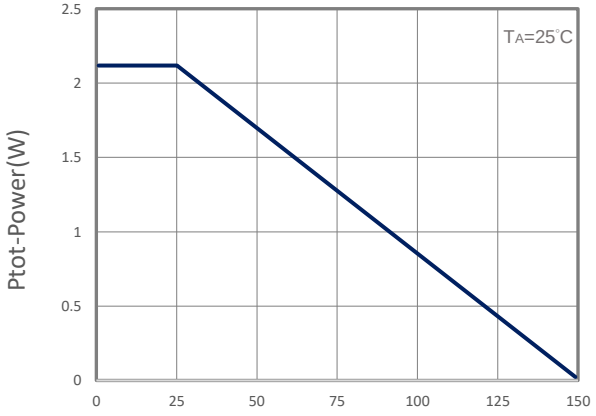
Gate Charge



Capacitance

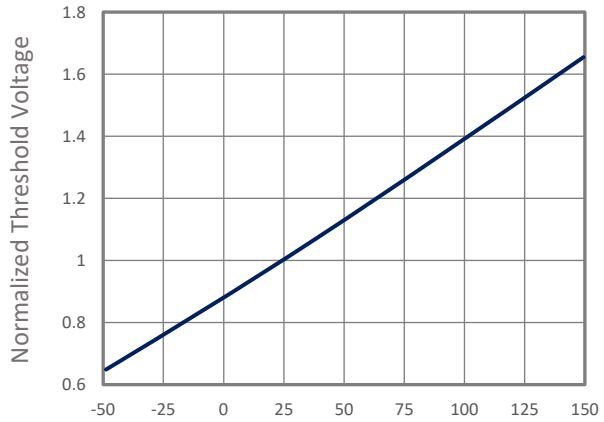


Gate Threshold Voltage

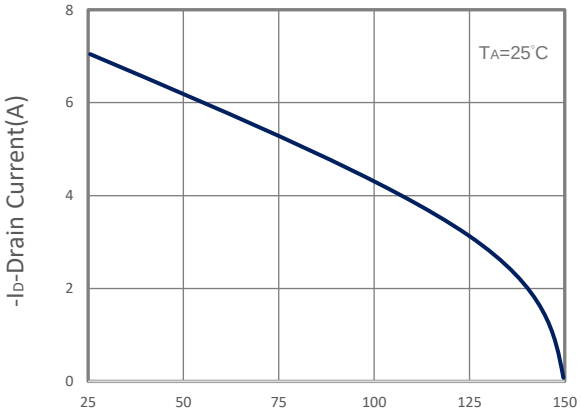


Power Dissipation

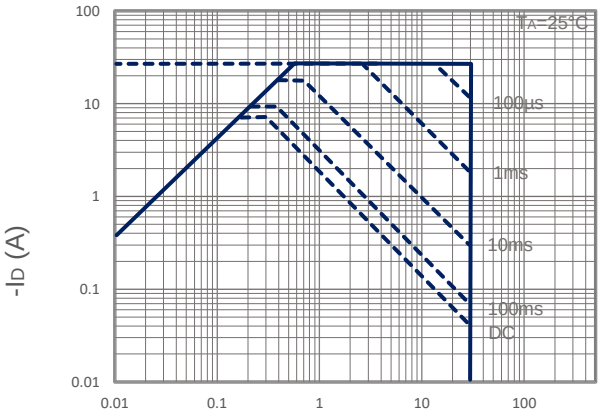
■P-ch TYPICAL CHARACTERISTICS



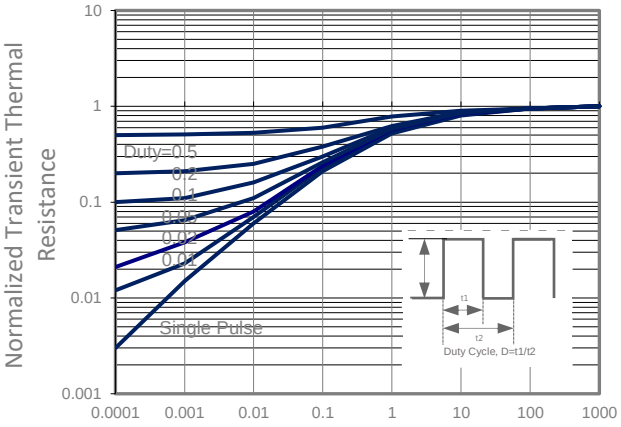
Gate Threshold Voltage



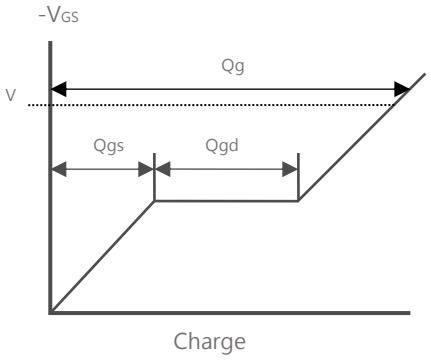
Drain Current vs TJ



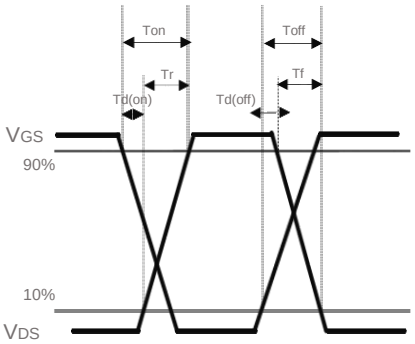
Maximum Safe Operation Area



Thermal Transient Impedance

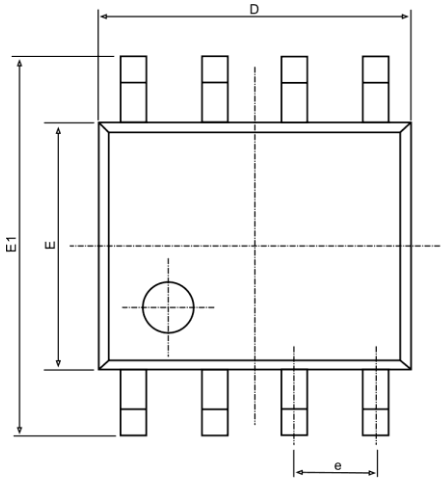


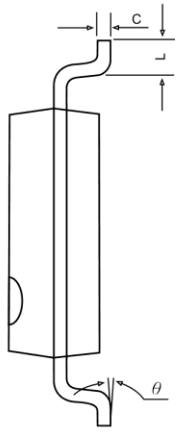
Gate Chrge Waveform

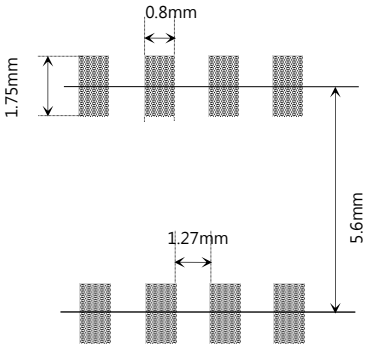


Switching Time Waveform

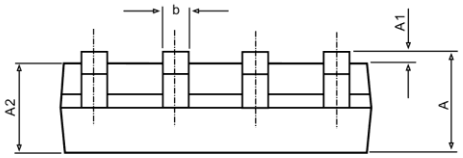
■SOP-8 PACKAGE DIMENSIONS







Recommended Land Pattern



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.040.	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.130	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270BSC.		0.050BSC.	
L	0.400	1.270	0.016	0.005
Θ	0°	8°	0°	8°